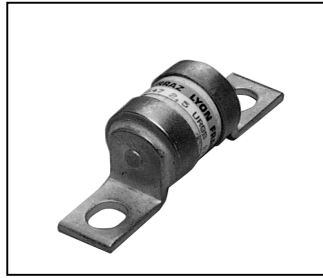




## FUSE TECHNOLOGIES AND OPERATION

1. MAIN TECHNOLOGIES
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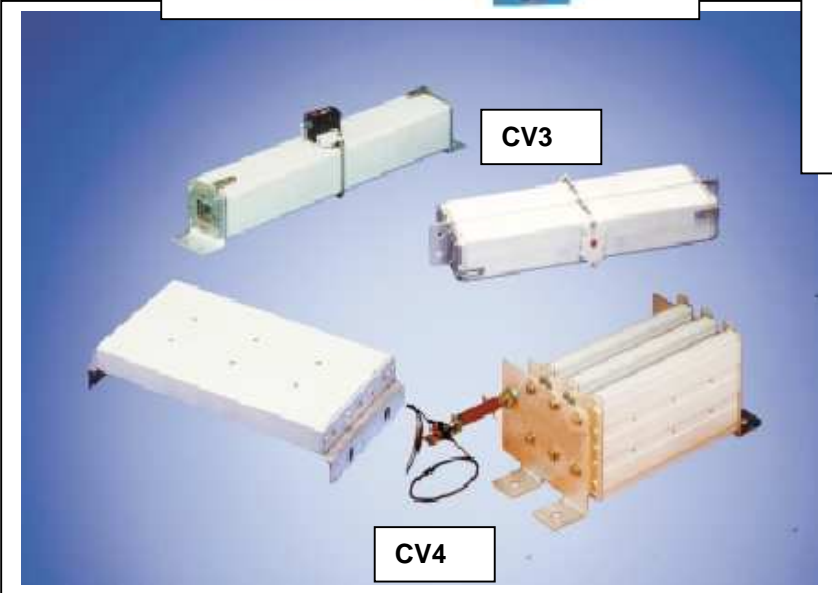
1. MAIN TECHNOLOGIES



American style  
semi conductor fuses



Rotating  
fuses



CV3

CV4

DIN 43620



Figure 6

## 2. DIFFERENT CONSTRUCTION EXAMPLES

### 2.1. PSC with flat end contacts - general view of the technology

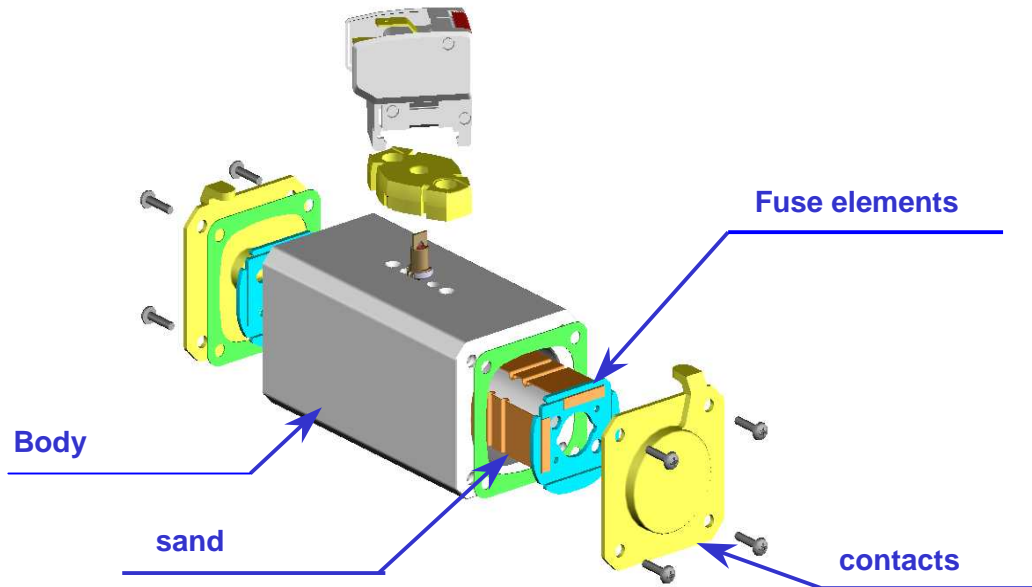


Figure 2

### 2.2. PSC-LR (C6) general view of the technology

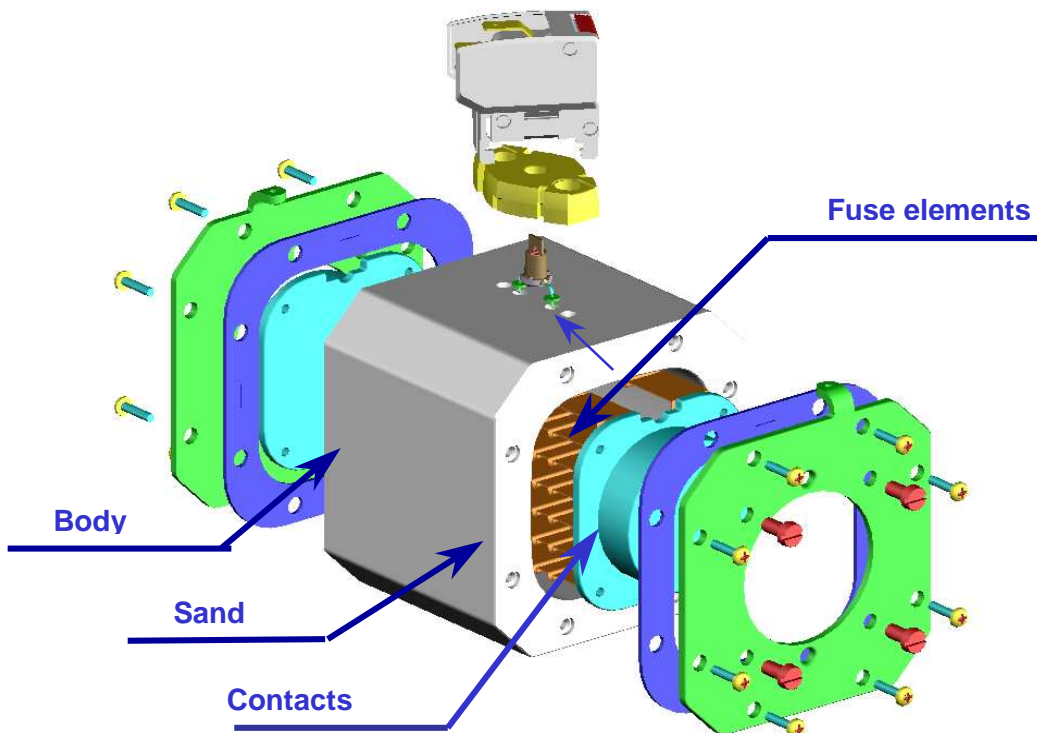


Figure 3

### 2.3. Standard gG NH style fuse

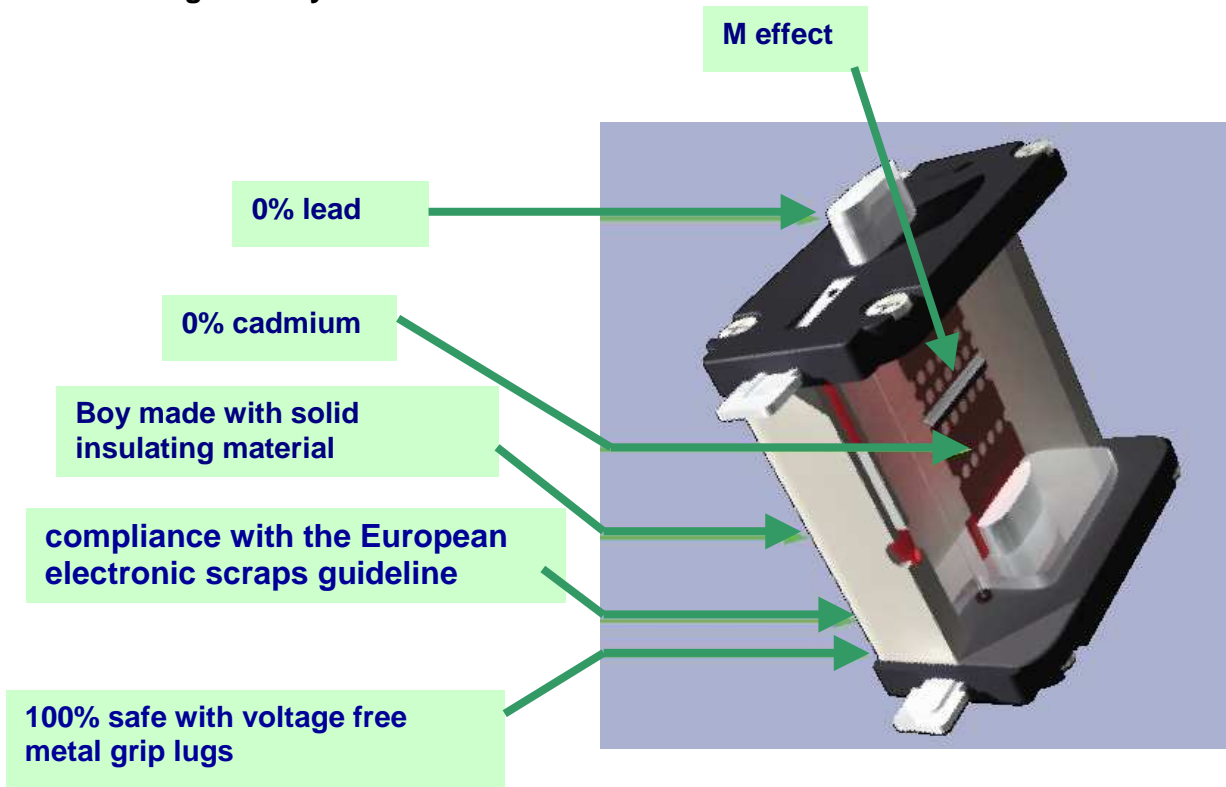


Figure 4

### 2.4. « Dual –Element » example for an American « Time Delay » fuse

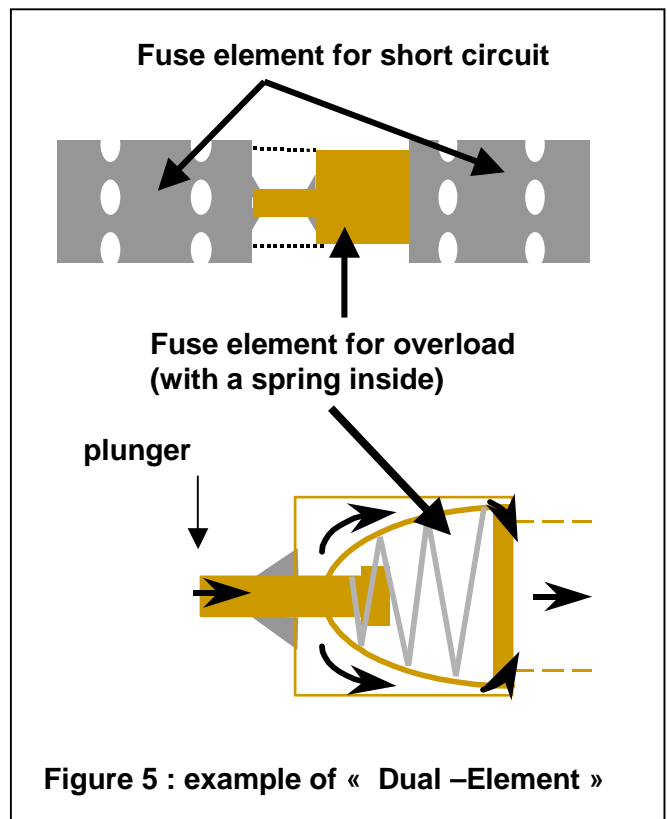


Figure 5 : example of « Dual –Element »

Figure 5 describes a « **Dual –Element** » and Clearly shows two types of fuse elements are in series:

- one element for short circuits interruptions
- one element for overloads interruptions equipped with a spring and highly thermally sensitive section
- Figure 12 in the last page shows another example of design.

### 3. OVERLOAD INTERRUPTION ( UP TO ABOUT 10 I<sub>N</sub>)

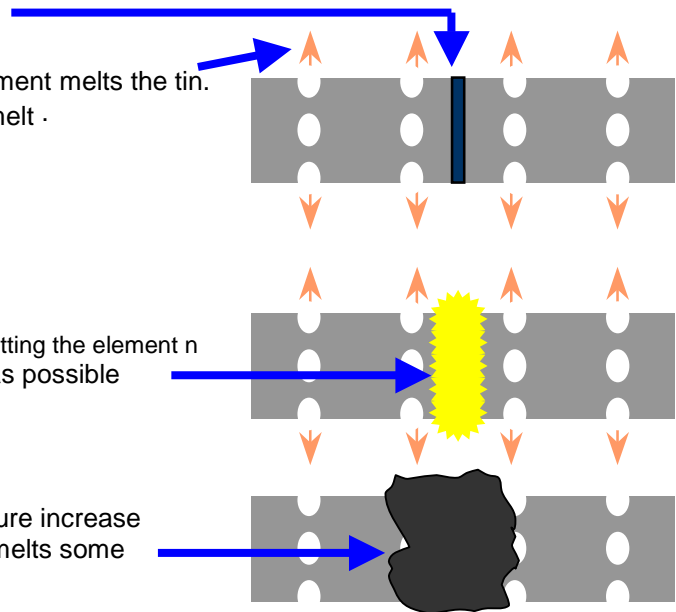
- Fast-acting :gG, gN, J, L ..fuses are designed to interrupt low overloads because they have fuse elements with M-effect . Figure 6
- Semiconductors Fuses type gR and gS only are designed to interrupt low overloads because they have fuse elements with M-effect . Figure 6

Tin or ( low melting temperature )

On sustained overload, heat produced by the element melts the tin.  
Tin & element form new alloy with much lower  $T_{melt}$  .

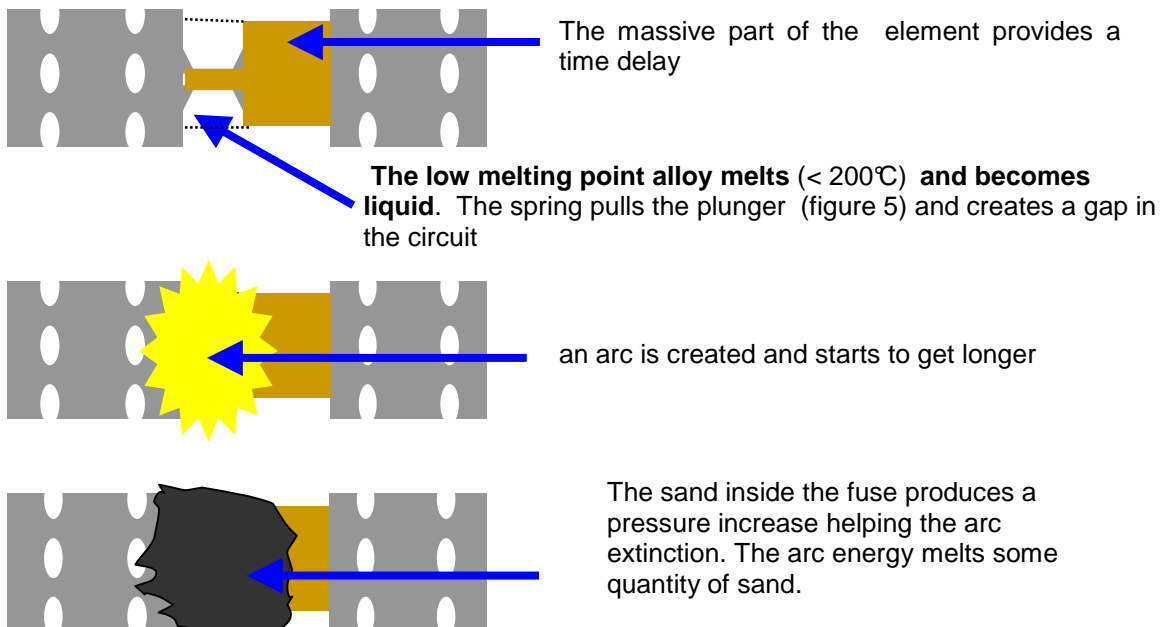
The tin goes through the element and creates a gap cutting the element in two pieces. An arc starts and tries to get as long as possible

The sand inside the fuse produces a pressure increase helping the arc extinction. The arc energy melts some quantity of sand.



**Figure 6: fuses gG, gR-, and UL fuses class J, L, H, CC ...**

- Time-delay : AJT, A4BQ, A6D, ATDR...fuses are designed to interrupt low overloads because they have fuse elements in 2 parts « Dual-Element ». Figure 7



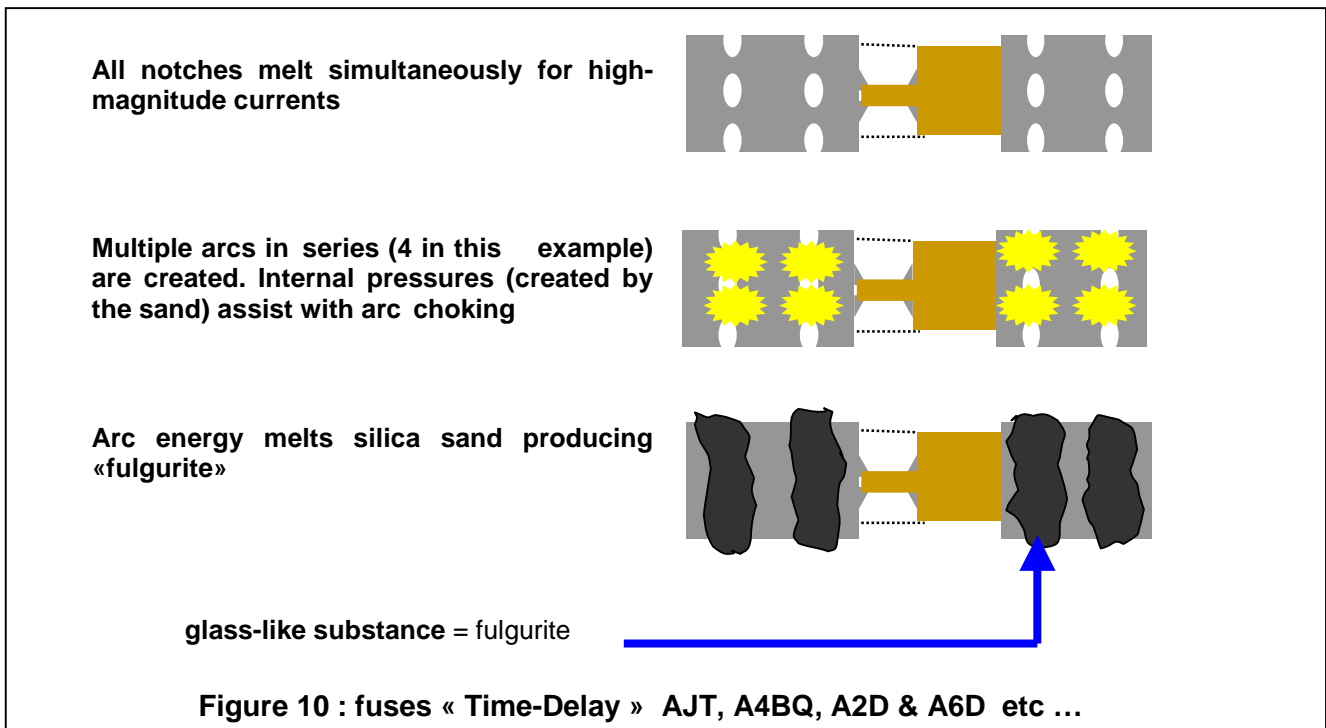
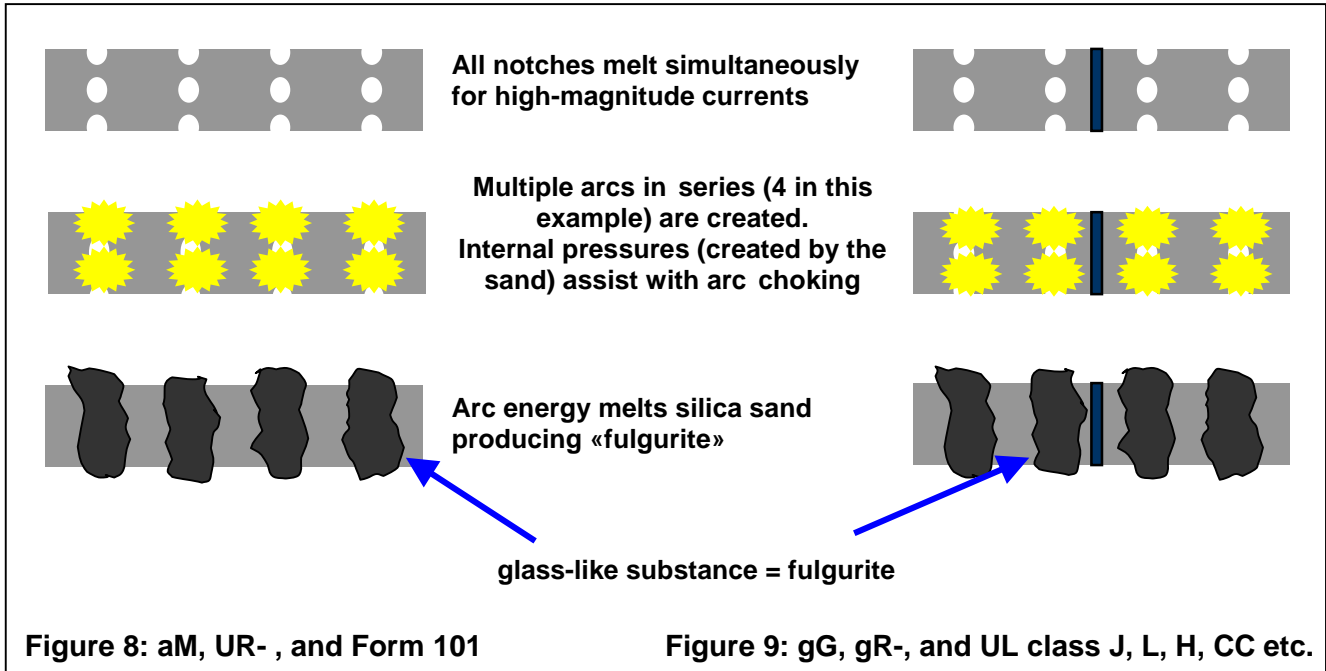
**Figure 7 : « Time-Delay » fuses AJT, A4BQ, A2D & A6D etc ...**

- UR and SR type Semiconductor Fuses are not designed to interrupt overloads
- aM type fuses can not interrupt overloads at times above 60 s

#### 4. SHORT CIRCUIT INTERRUPTION (GENERALLY ABOVE 10 I<sub>N</sub>)

All fuse types create several arcs in series by melting several rows of constrictions in to obtain a better control of the arc. The sand is absolutely necessary in order to obtain:

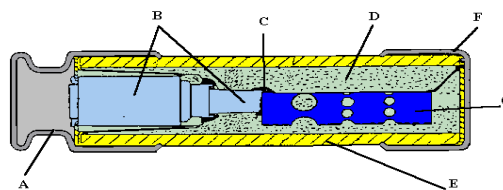
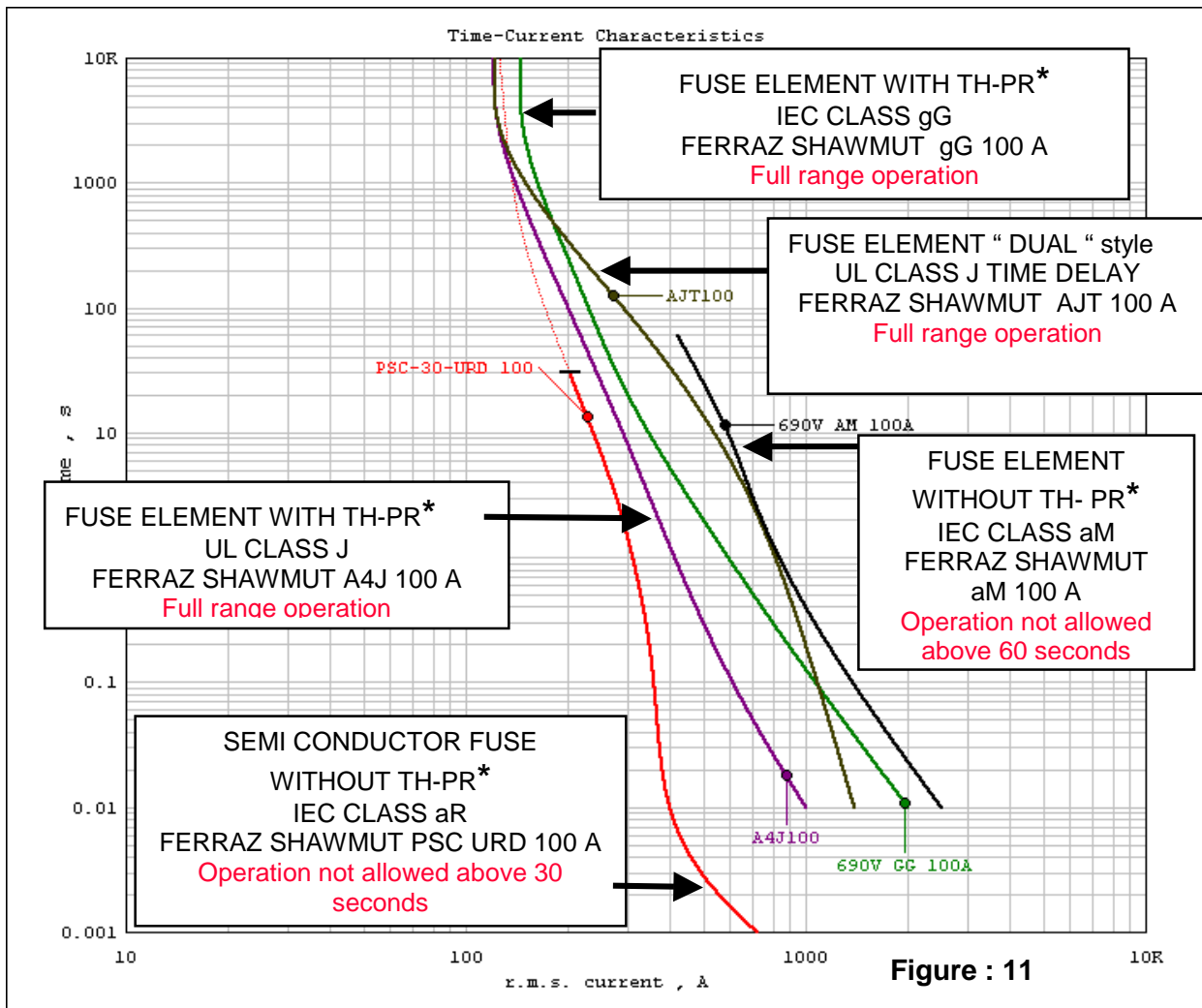
- the shortest arc time
- the best current limitation
- less I<sup>2</sup>t and energy



- Figures 8, 9 et 10 show all fuse types described in IEC 60269 and UL 248 standards interrupt a short circuit exactly in the same manner. However there are some differences in the speed. For example a fuse for semi conductor protection is much faster than an aM fuse or a « Time-Delay » fuse.

## 5. COMPARAISON DE 5 COURBES

\* TH-PR = THERMO-PROTECTION



- A. Capsule pour système de réjection
- B. Élément fusible pour surcharge
- C. Soudure avec eutectique
- D. Sable
- E. Corps
- F. Capsule standard
- G. Élément fusible pour court-circuit

Figure 12 : another example of « Dual Element » .  
Fusible class RK5, FERRAZ SHAWMUT type TRS